

# Search Notes



Application/Control No.

09/757,491

Examiner

Jennifer T. Nguyen

Applicant(s)/Patent under  
Reexamination

TANAKA ET AL.

Art Unit

2674

## SEARCHED

Class	Subclass	Date	Examiner
345	76	7/19/05	JN
	82		
	77		
	78		
	92		
315	169.1-		
	169.3		

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
East Search	7/19/05	JN